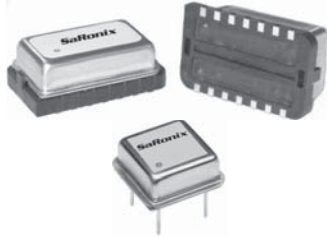


Technical Data

NTH / NCH Series



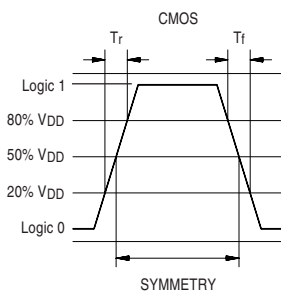
Description

A crystal controlled, low current, low jitter and high frequency oscillator with precise rise and fall times demanded in networking applications. The tri-state function on the NTH enables the output to go high impedance. Device is packaged in a 14 or an 8-pin DIP compatible resistance welded, all metal grounded case to reduce EMI. True SMD DIL14 versions for IR reflow are available, select option "S" in part number builder. See separate data sheet for SMD package dimensions.

Applications & Features

- ADSL, DSL
- DS3, ES3, E1, STS-1, T1
- Ethernet Switch, Gigabit Ethernet
- Fibre Channel Controller
- MPEG
- Network Processors
- Voice Over Packet
- 32 Bit Microprocessors
- Tri-State output on NTH
- LVCMOS / HCMOS compatible
- Available up to 106.25 MHz

Output Waveform



Frequency Range:	0.5 MHz to 106.25 MHz																		
Frequency Stability:	±20, ±25, ±50 or ±100 ppm over all conditions: calibration tolerance, operating temperature, input voltage change, load change, 30 day aging, shock and vibration.																		
Temperature Range:	Operating: 0 to +70°C or -40 to +85°C, See Part Numbering Guide Storage: -55 to +125°C																		
Supply Voltage:	Recommended Operating: 3.3V ±10%																		
Supply Current:	20mA max, 0.5 to 30 MHz 25mA max, 30+ to 50 MHz 30mA max, 50+ to 80 MHz 35mA max, 80+ to 106.25 MHz																		
Output Drive:	<table border="0"> <tr> <td>HCMOS</td> <td>Symmetry:</td> <td>45/55% max 0.5 to 70 MHz max 40/60% max @ 50% VDD</td> </tr> <tr> <td></td> <td>Rise and Fall Times:</td> <td>4ns max 0.5 to 50 MHz, 20% to 80% VDD 3ns max 50+ to 80 MHz 1.5ns max 80+ to 106.25 MHz</td> </tr> <tr> <td></td> <td>Logic 0:</td> <td>10% VDD max</td> </tr> <tr> <td></td> <td>Logic 1:</td> <td>90% VDD min</td> </tr> <tr> <td></td> <td>Load:</td> <td>50pF, 0.5 to 50 MHz 30pF, 50+ to 70 MHz 15pF, 70+ to 106.25 MHz</td> </tr> <tr> <td></td> <td>Period Jitter RMS:</td> <td>8ps max</td> </tr> </table>	HCMOS	Symmetry:	45/55% max 0.5 to 70 MHz max 40/60% max @ 50% VDD		Rise and Fall Times:	4ns max 0.5 to 50 MHz, 20% to 80% VDD 3ns max 50+ to 80 MHz 1.5ns max 80+ to 106.25 MHz		Logic 0:	10% VDD max		Logic 1:	90% VDD min		Load:	50pF, 0.5 to 50 MHz 30pF, 50+ to 70 MHz 15pF, 70+ to 106.25 MHz		Period Jitter RMS:	8ps max
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Mechanical:	<table border="0"> <tr> <td>Shock:</td> <td>MIL-STD-883, Method 2002, Condition B</td> </tr> <tr> <td>Solderability:</td> <td>MIL-STD-883, Method 2003</td> </tr> <tr> <td>Terminal Strength:</td> <td>MIL-STD-883, Method 2004, Conditions A & C</td> </tr> <tr> <td>Vibration:</td> <td>MIL-STD-883, Method 2007, Condition A</td> </tr> <tr> <td>Solvent Resistance:</td> <td>MIL-STD-202, Method 215</td> </tr> <tr> <td>Resistance to Soldering Heat:</td> <td>MIL-STD-202, Method 210, Condition A, B or C</td> </tr> </table>	Shock:	MIL-STD-883, Method 2002, Condition B	Solderability:	MIL-STD-883, Method 2003	Terminal Strength:	MIL-STD-883, Method 2004, Conditions A & C	Vibration:	MIL-STD-883, Method 2007, Condition A	Solvent Resistance:	MIL-STD-202, Method 215	Resistance to Soldering Heat:	MIL-STD-202, Method 210, Condition A, B or C						
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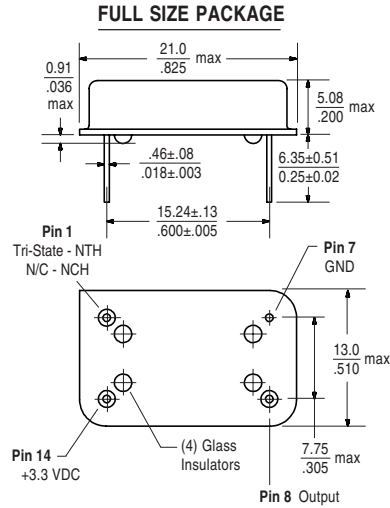
Environmental:

Gross Leak Test:	MIL-STD-883, Method 1014, Condition C
Fine Leak Test:	MIL-STD-883, Method 1014, Condition A2
Thermal Shock:	MIL-STD-883, Method 1011, Condition A
Moisture Resistance:	MIL-STD-883, Method 1004

Technical Data

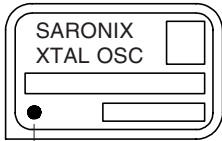
NTH / NCH Series

Package Details



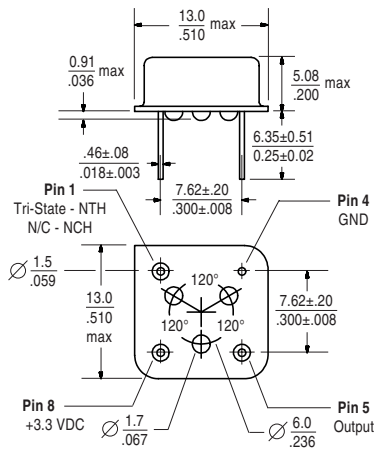
Standard Marking Format**

Includes Date Code, Frequency & Part Number



Denotes Pin 1

HALF SIZE PACKAGE



Standard Marking Format**

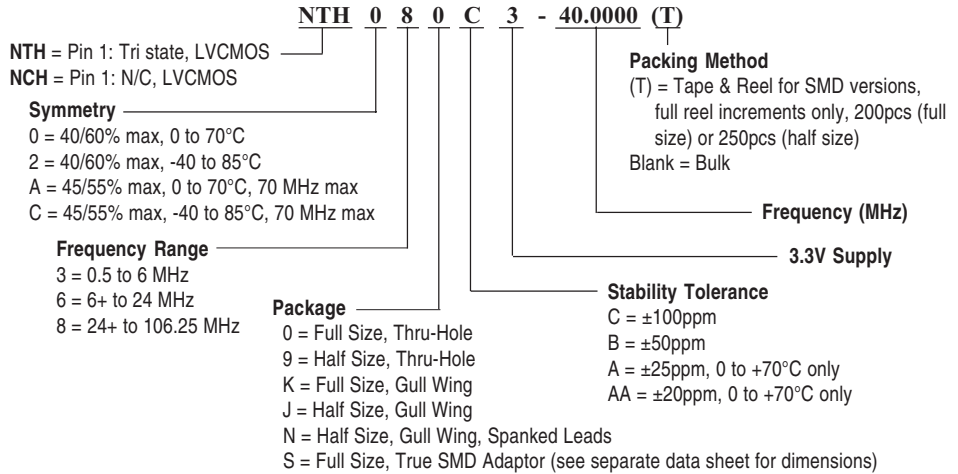
Includes Date Code, Frequency & Part Number



Denotes Pin 1

**Exact location of items may vary

Part Numbering Guide



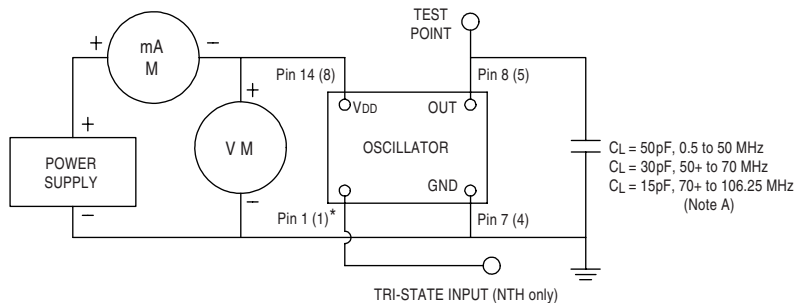
Tri-State Logic Table (NTH only)

Pin 1 Input	Pin 8 (5) Output
Logic 1 or NC	Oscillation
Logic 0 or GND	High Impedance

Required Input Levels on Pin 1:
Logic 1 = 2.2V min
Logic 0 = 0.8V max

Output: Oscillation @ V_{IN} , 2.2V min
Output: High Impedance @ V_{IN} , 0.8V max
Internal Pullup Resistance: 50K Ω min
Control Input: Disable Output Delay: 100ns max

Test Circuit



NOTE A: C_L includes probe and fixture capacitance
*() Indicates pin numbers for half-size package

All specifications are subject to change without notice.

True SMD Adaptor - 7.57mm High

Technical Data

